

National Semiconductor

June 1999

LP3470

Tiny Power On Reset Circuit

General Description

The LP3470 is a micropower CMOS voltage supervisory circuit designed to monitor power supplies in microprocessor (µP) and other digital systems. It provides maximum adjustability for power-on-reset (POR) and supervisory functions. It is available in the following six standard reset threshold voltage (V_{RTH}) options: 2.63V, 2.93V, 3.08V, 4.00V, 4.38V, and 4.63V. If other voltage options between 2.4V and 5.0V are desired please contact your National Semiconductor representative.

The LP3470 asserts a reset signal whenever the $V_{\rm CC}$ supply voltage falls below a reset threshold. The reset time-out period is adjustable using an external capacitor. Reset remains asserted for an interval (programmed by an external capacitor) after $V_{\rm CC}$ has risen above the threshold voltage.

The device is available in the tiny SOT23-5 package.

Key Specifications

- ±1% Reset Threshold Accuracy Over Temperature
- Standard Reset Threshold Voltages: 2.63V, 2.93V, 3.08V, 4.00V, 4.38V, and 4.63V

- Custom Reset Threshold Voltages: For other voltages between 2.4V and 5.0V contact your National Semiconductor representative
- Very Low Quiescent Current (16 µA typical)
- Guaranteed Reset valid down to V_{CC}=0.5V

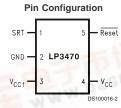
Features

- Tiny SOT23-5 Package
- Open Drain Reset Output
- Programmable Reset Timeout Period Using an External Capacitor
- Immune to Short V_{CC} Transients

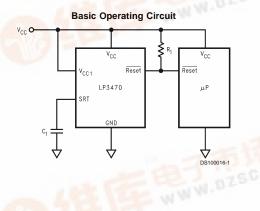
Applications

- Critical µP and µC Power Monitoring
- Intelligent Instruments
- Computers
- Portable/Battery-Powered Equipments

Pin Configuration and Basic Operating Circuit



Top View See NS Package Number MA05B





Operating Temperature Range	Order Number	Nominal V _{RTH} (V)	Package Marking	Package Type	Supplied As
	LP3470M5-2.63	2.63	D25B	SOT23-5	250 Units on Tape and Ree
	LP3470M5X-2.63	2.63	D25B	SOT23-5	3k Units on Tape and Reel
	LP3470M5-2.93	2.93	D26B	SOT23-5	250 Units on Tape and Ree
	LP3470M5X-2.93	2.93	D26B	SOT23-5	3k Units on Tape and Reel
	LP3470M5-3.08	3.08	D28B	SOT23-5	250 Units on Tape and Ree
−20°C to	LP3470M5X-3.08	3.08	D28B	SOT23-5	3k Units on Tape and Reel
+85°C	LP3470M5-4.00	4.00	D29B	SOT23-5	250 Units on Tape and Ree
	LP3470M5X-4.00	4.00	D29B	SOT23-5	3k Units on Tape and Reel
	LP3470M5-4.38	4.38	D30B	SOT23-5	250 Units on Tape and Rea
	LP3470M5X-4.38	4.38	D30B	SOT23-5	3k Units on Tape and Reel
	LP3470M5-4.63	4.63	D31B	SOT23-5	250 Units on Tape and Rec
	LP3470M5X-4.63	4.63	D31B	SOT23-5	3k Units on Tape and Reel
	LP3470IM5-2.63	2.63	D25C	SOT23-5	250 Units on Tape and Ree
	LP3470IM5X-2.63	2.63	D25C	SOT23-5	3k Units on Tape and Reel
	LP3470IM5-2.93	2.93	D26C	SOT23-5	250 Units on Tape and Ree
	LP3470IM5X-2.93	2.93	D26C	SOT23-5	3k Units on Tape and Reel
-40°C to +85°C	LP3470IM5-3.08	3.08	D28C	SOT23-5	250 Units on Tape and Rec
	LP3470IM5X-3.08	3.08	D28C	SOT23-5	3k Units on Tape and Reel
	LP3470IM5-4.00	4.00	D29C	SOT23-5	250 Units on Tape and Rec
	LP3470IM5X-4.00	4.00	D29C	SOT23-5	3k Units on Tape and Reel
	LP3470IM5-4.38	4.38	D30C	SOT23-5	250 Units on Tape and Re
	LP3470IM5X-4.38	4.38	D30C	SOT23-5	3k Units on Tape and Reel
	LP3470IM5-4.63	4.63	D31C	SOT23-5	250 Units on Tape and Re
	LP3470IM5X-4.63	4.63	D31C	SOT23-5	3k Units on Tape and Reel

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Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

V_{CC} Voltage -0.3V to +6VReset Voltage Output Current (Reset)

-0.3V to +6V 10 mA

LP3470 -20°C to +85°C LP3470I -40°C to +85°C Junction Temperature (T_{Jmax}) 125°C Power Dissipation (T_A = 25°C) (Note 300 mW θ_{JA} (Note 2) 280°C/W Storage Temp. Range -65°C to +150°C Lead Temp. (Soldering, 5 sec) 260°C

2 kV

Operating Temperature Range

ESD Rating (Note 3)

Electrical Characteristics

Limits in standard typeface are for $T_J = 25^{\circ}C$, and limits in **boldface** type apply over the full operating temperature range, unless otherwise specified. $V_{CC} = +2.4V$ to +5.0V unless otherwise noted.

Symbol	Parameter	Conditions	Typ (Note 4)	Min (Note 5)	Max (Note 5)	Units
V _{CC}	Operating Voltage Range			0.5	5.5	V
I _{cc}	V _{CC} Supply Current	V _{CC} = 4.5V	16		30	μA
V _{RTH}	Reset Threshold Voltage (Note 6)	LP3470	V _{RTH}	0.99 V _{RTH} 0.99 V_{RTH}	1.01 V _{RTH} 1.01 V _{RTH}	V
		LP3470I	V _{RTH}	0.99 V _{RTH} 0.985 V_{RTH}	1.01 V _{RTH} 1.015 V _{RTH}	V
V _{HYST}	Hysteresis Voltage (Note 7)		35	15	65	mV
t _{PD}	V _{CC} to Reset Delay	V _{CC} falling at 1 mV/µs	100		300	μs
t _{RP}	Reset Timeout Period (Note 8)	C ₁ = 1 nF	2	1.0	3.5	ms
V _{OL}	Reset Output Voltage Low	$V_{CC} = 0.5V; I_{OL} = 30 \mu A$			0.1	
		V _{CC} = 1.0V; I _{OL} = 100 μA			0.1	V
		$V_{CC} = V_{RTH} - 100 \text{ mV}; I_{OL} = 4 \text{ mA}$			0.4	v
R ₁	External Pull-up Resistor		20	0.68	68	kΩ
I _{LEAK}	Reset Output Leakage Current		0.15		1 6	μA

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Electrical specifications do not apply when operating the device beyond its operating conditions.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{Jmax} (Maximum Junction Temperature), θ_{JA} (Junction to Ambient Thermal Resistance), and T_A (Ambient Temperature). The maximum allowable power dissipation at any temperature is $P_{Dmax} = (T_{Jmax} - T_A)/\theta_{JA}$ or the number given in the Absolute Maximum Ratings, whichever is lower.

Note 3: The Human Body Model is a 100 pF capacitor discharged through a 1.5 k Ω resistor into each pin.

Note 4: Typical numbers are at 25°C and represent the most likely parametric norm.

Note 5: Min. and Max. limits in standard typeface are 100% production tested at 25°C. Min. and Max. limits in boldface are guaranteed through correlation using Statistical Quality Control (SQC) methods. The limits are used to calculate National's Average Outgoing Quality Level (AOQL).

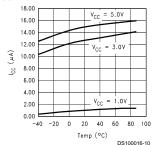
Note 6: Factory-trimmed reset thresholds are available in 50 mV increments from 2.4V to 5.0V. Contact your National Semiconductor representative.

Note 7: V_{HYST} affects the relation between V_{CC} and \overline{Reset} as shown in the timing diagram.

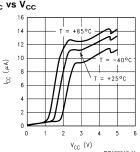
Note 8: t_{RP} is programmable by varying the value of the external capacitor (C₁) connected to pin SRT. The equation is: $t_{RP} = 2000 \times C_1$ (C₁ in μ F and t_{RP} in ms).

Typical Operating Characteristics $T_A = +25$ °C, unless otherwise specified.

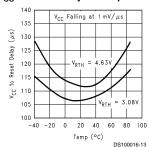
I_{CC} vs Temperture



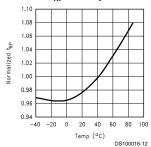
 $I_{\rm CC}$ vs $V_{\rm CC}$



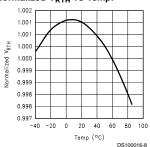
V_{CC} to Reset Delay vs Temp



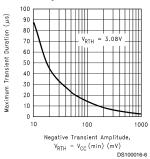
Normalized t_{RP} vs Temp.



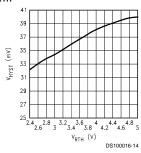
Normalized $\rm V_{\rm RTH}$ vs Temp.



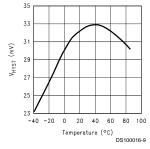
Transient Rejection



 $V_{\rm HYST}$ vs $V_{\rm RTH}$



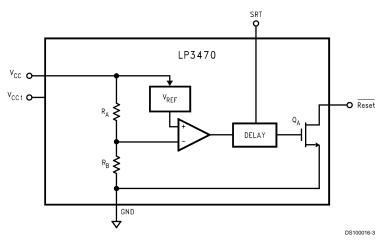
V_{HYST} vs Temperature



Pin Description

Pin	Name	Function		
1	SRT	Set Reset Time-out Input. Connect a capacitor between this input and ground to select the Reset Time-out period (t_{RP}). t_{RP} = 2000 x C ₁ (C ₁ in μ F and t_{RP} in ms). If no capacitor is connected, leave this pin floating.		
2	GND	Ground pin.		
3	V _{CC1}	Always connect to pin V _{CC} (Pin 4).		
4	V _{cc}	Supply voltage, and reset threshold monitor input.		
5	Reset	Open-Drain, Active-Low reset output. Connect to an external pull-up resistor. Reset changes from high to low whenever the monitored voltage (V_{CC}) drops below the reset threshold voltage (V_{RTH}). Once V_{CC} exceeds V_{RTH} , Reset remains low for the reset timeout period (t_{RP}) and then goes high.		

Functional Block Diagram



Application Information

Reset Timeout Period

The Reset Timeout Period ($t_{\rm RP}$) is programmable using an external capacitor (C_1) connected to pin SRT of LP3470. A Ceramic chip capacitor rated at or above 10V is sufficient. The Reset Timeout Period ($t_{\rm RP}$) can be calculated using the following formula:

$$t_{RP}$$
 (ms) = 2000 x C_1 (μF).

For example a $\rm C_1$ of 100 nF will achieve a $\rm t_{RP}$ of 200 ms. If no delay due to $\rm t_{RP}$ is needed in a certain application, the pin SRT should be left floating.

Reset Output

In applications like microprocessor (μP) systems, errors might occur in system operation during power-up, power-down, or brownout conditions. It is imperative to monitor the power supply voltage in order to prevent these errors from occurring.

The LP3470 asserts a reset signal whenever the $V_{\rm CC}$ supply voltage is below a threshold ($V_{\rm RTH}$) voltage. Reset is guaranteed to be a logic low for $V_{\rm CC} > 0.5$ V. Once $V_{\rm CC}$ exceeds the reset threshold, the reset is kept asserted for a time period ($t_{\rm RP}$) programmed by an external capacitor (C_1); after this interval Reset goes to logic high. If a brownout condition occurs (monitored voltage falls below the reset threshold minus a small hysteresis), Reset goes low. When $V_{\rm CC}$ returns above the reset threshold, Reset remains low for a time period $t_{\rm RP}$ before going to logic high.

Pull-up Resistor Selection

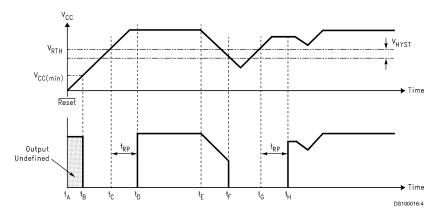
The LP3470's \overline{Reset} output structure is a simple open-drain N-channel MOSFET switch. A pull-up resistor (R1) should be connected to $V_{\rm CC}.$

 R_1 should be large enough to limit the current through the output MOSFET (Q_1) below 10 mA. A resistor value of more than 680Ω guarantees this. R_1 should also be small enough to ensure a logic high while supplying all the leakage current through the Reset pin. A resistor value of less than $68k\Omega$ satisfies this condition. A typical pull-up resistor value of $20~k\Omega$ is sufficient in most applications.

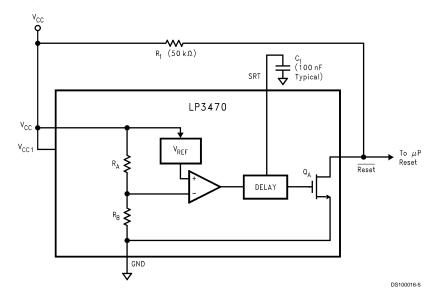
Negative-Going V_{CC} Transients

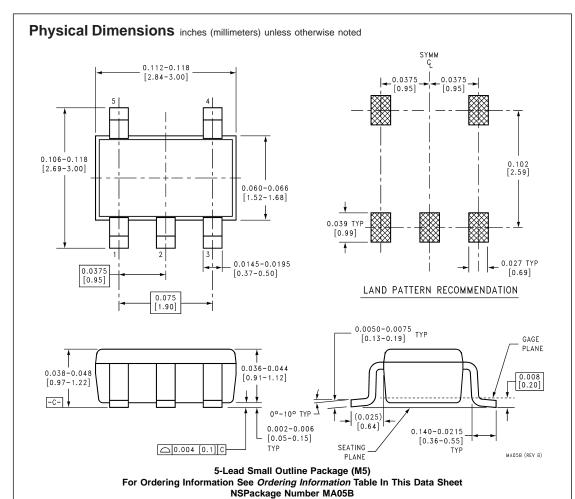
The LP3470 is relatively immune to short duration negative-going $V_{\rm CC}$ transients (glitches). The Typical Operating Characteristics show the Maximum Transient Duration vs. Negative Transient Amplitude (graph titled Transient Rejection), for which reset pulses are not generated. This graph shows the maximum pulse width a negative-going $V_{\rm CC}$ transient may typically have without causing a reset pulse to be issued. As the transient amplitude increases (i.e. goes farther below the reset threshold), the maximum allowable pulse width decreases. A 0.1 $\mu\rm F$ bypass capacitor mounted close to $V_{\rm CC}$ provides additional transient immunity.

Timing Diagram



Typical Application Circuit





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